

Analytical Reference Materials International

Certificate of Analysis Certified Reference Material



Grade: **AISI 317L / UNS S31703**

Part Number (Q.A. NO.): **IARM 153B**

Certification Date: **01/21/2003**

Certificate No.: **153B-01212003-IARM-F**

Revision Date: **04/30/2003**

Interpretation of Data

1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community.
2. Any data reported and enclosed by a **parentheses ()** is a **"best estimate"** and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
3. The "Inter-laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets []** indicates **further testing is in process**.
4. The "**± Confidence Interval at 95%**" is enclosed by a **parentheses ()** below the individual element's concentration.

IMPORTANT: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

<u>Aluminum</u> 0.006 (0.001)	<u>Boron</u> 0.0022 (0.0004)	<u>Carbon</u> 0.015 (0.001)	<u>Cobalt</u> 0.115 (0.004)	<u>Chromium</u> 18.13 (0.05)	<u>Copper</u> 0.408 (0.007)	<u>Manganese</u> 1.58 (0.01)
<u>Molybdenum</u> 3.12 (0.02)	<u>Nitrogen</u> 0.0158 (0.0008)	<u>Niobium</u> 0.008 (0.002)	<u>Nickel</u> 13.19 (0.03)	<u>Oxygen</u> 0.0052 (0.0004)	<u>Phosphorus</u> 0.031 (0.002)	<u>Sulfur</u> 0.0082 (0.0002)
<u>Silicon</u> 0.28 (0.005)	<u>Tin</u> 0.014 (0.002)	<u>Titanium</u> 0.002 (0.0005)	<u>Vanadium</u> 0.031 (0.002)	<u>Tungsten</u> 0.020 (0.003)		

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

AK Steel, Butler Works - Butler, PA
Allvac Lockport - Lockport, NY
Carpenter Technology Corporation - Reading, PA
Conam Inspection - Gary, IN
Laboratory Testing, Inc. - Hatfield, PA
Timken Latrobe Steel Co. - Latrobe, PA

Allegheny Ludlum Corp. - Brackenridge, PA
Anderson Laboratories, Inc. - Greendale, WI
Chicago Spectro Service Laboratories - Chicago, IL
Jorgensen Forge Corp. - Seattle, WA
Lockheed Martin Astronautics - Littleton, CO
Wisconsin Centrifugal, Inc. - Waukesha, WI

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs and RMs applicable to the material covered by this certificate are: NIST 1226, 1261A, 1262A, 1265A, C1151, C1152, C1153, C1154, 1155, 1193, 1194, 1195, 1230, C2400, JSS 650, 651, 652, 653, 654, 655, BCS331, 332, 333, 334, 335, 336, 337, 338, ARMCO 8709, 8710, 8711, 8712, MBH14933, 14934, 14935, BSC 401/1, 402/1, 403/1, 404/1, 405/1, 406/1, 407/1, 408/1, 409/1, 410/1, IARM 1B, 2B, 4B, 5B, 9B, 11B, 152A, 157A162A, 163A, 205A, 27B, 28B, 29B, 30B, 31B, 32B, 33B, 34B, 35B, 36B, 48B, 49B, 155A, 156A, 164A, 165A, 166A, 167A, 168A, 169A, 170A, 171A, 172A, BS 317L, IARM 2A, 163A, 5A, NIST 1188, 1170A, 1184, NIST 121D, 160A, 133A, 1091A, IARM 5C, NIST 1761-1767, 368, 1155, 15, LECO 501-553, 501-550, 762-747, IARM 24A, RE 12BS 84J, JSS 190, BAS 66, CS 44C, NIST 15H, 343A, 73C, BS CA316-1, 84J, 317L, SS 466, 474, IARM 153A, AK 420400, B-85, 220790, V3505-2, LECO 502-106, LECO 502-148, 501-553, BS 317L, IARM 5A, BS 317I, Cartech 316, NIST 160A, 443, 444, IARM 153A, LECO 501-676, 501-553, IS0049A, IC17910, IARM 153A, 27B, NIST 362, LECO 501-647, BS 317L, 84J, RV 9963, IARM 5C, BAS SS474, LECO 501-674, 502-106, 502-256, BS 84J, CA316-1, BAS 474, NIST 1155, LECO 501-502, 501-551, 501-550

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

See Reverse Side for Statistical Data and Additional Information Regarding this Material.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 04/30/2003.

153B	Al	B	C	Co	Cr	Cu	Mn	Mo	N	Nb	Ni	O	P	S	Se
1	0.007	0.0019	0.014	0.109	18.14	0.422	1.55	3.13	0.0149	0.0070	13.23	0.0051	0.0292	0.0085	0.0015
2	0.00423	0.0024	0.016	0.12512	18.08	0.407	1.592	3.101	0.0139	0.009	13.18	0.0057	0.028	0.0081	<0.0001
3	0.0059	0.00237	0.0140	0.107	18.273	0.4099	1.5729	3.154	0.0169	0.007	13.23	0.0045	0.03345	0.0085	0.0064
4	0.005	0.0023	0.014	0.1192	18.04	0.407	1.57	3.09	0.0162	0.012	13.205	0.0059	0.034	0.0081	<0.001
5	0.00696	0.0024	0.0148	0.105	18.243	0.406	1.596	3.110	0.0162	0.005	13.231	0.0040	0.0280	0.0076	<0.001
6	0.0083	0.0016	0.0142	0.109	18.081	0.401	1.579	3.112	0.0167	0.006	13.157	0.0049	0.032	0.0078	0.001
7	0.006		0.0165	0.116	18.181	0.386	1.563	3.101	0.0140	0.0105	13.258	0.0058	0.0336	0.0084	
8	0.004		0.0170	0.118	18.053	0.427	1.572	3.17	0.0165		13.14	0.0048	0.028	0.00835	
9			0.0145	0.117	18.00	0.402	1.59	3.15	0.0162		13.13	0.0052	0.0296	0.0081	
10			0.0152	0.118	18.12	0.406	1.575	3.115	0.0156		13.219	0.0056	0.0332		
11				0.122	18.160	0.411	1.593	3.114	0.0172		13.153		0.0319		
12				0.116	18.064		1.590	3.115					0.032		
13					18.21		1.588								
Mean	0.0059	0.0022	0.0150	0.1151	18.1265	0.4077	1.5793	3.1218	0.0158	0.0081	13.1939	0.0052	0.0311	0.0082	0.0030
STDV.	0.0015	0.0003	0.0011	0.0062	0.0833	0.0107	0.0137	0.0243	0.0011	0.0025	0.0437	0.0006	0.0024	0.0003	0.0030
Certified	0.006	0.0022	0.015	0.115	18.13	0.408	1.58	3.12	0.0158	0.008	13.19	0.0052	0.031	0.0082	
95% C.I.	0.001	0.0004	0.001	0.004	0.05	0.007	0.01	0.02	0.0008	0.002	0.03	0.0004	0.002	0.0002	
Methods	X,I,O	O	C,O	X,I,O	X,W,O	X,I,O	X,I,O	X,I,O	F	X,O	X,W,O	F	X,I,O	C,X,O	

Methods: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G=GDMS

153B	Si	Sn	Ta	Ti	V	W	Ag	As	Bi	Ca	H	Mg	Pb	Te	Zr
1	0.27	0.016	0.0114	0.002	0.0282	0.015	<0.0001	0.0017	<0.0001	0.0289	0.0001	<0.0001	0.0023	0.0007	0.0102
2	0.287	0.01839	0.0021	0.00265	0.031	0.023		0.0023	0.0001	0.0013		0.0012	0.0001	<0.0001	<0.0001
3	0.2773	0.015	<0.01	0.001	0.0323	0.024		0.0059	0.0027			<0.001	0.0008		0.0027
4	0.28	0.012	<0.001	0.0018	0.031	0.018		0.00953	0.00076				<0.0005		0.0018
5	0.2948	0.0172	0.001	0.0014	0.0309	0.0152		0.0046	<0.001				0.00471		
6	0.271	0.011	0.011	0.002	0.027	0.022							0.0002		
7	0.283	0.0134		0.0011	0.033	0.018							0.0011		
8	0.274	0.0150			0.031	0.022									
9	0.287	0.0123			0.028										
10	0.283				0.0339										
11	0.288														
12	0.286														
Mean	0.2818	0.0145	0.0064	0.0017	0.0306	0.0197	#DIV/0!	0.0048	0.0012	0.0151	0.0001	0.0012	0.0015	0.0007	0.0049
STDV.	0.0075	0.0025	0.0056	0.0006	0.0023	0.0035	#DIV/0!	0.0031	0.0014	0.0195	#DIV/0!	#DIV/0!	0.0017	#DIV/0!	0.0046
Certified	0.28	0.014	<0.01	0.002	0.031	0.020		(0.005)					<0.002		
95% C.I.	0.005	0.002		0.0005	0.002	0.003									
Methods	X,W,O	X,O	X,I,O	X,O	X,I,O	X,O		X,A,O					X,D,A,O		

Methods: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G=GDMS

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1981-(E) list the following:

Certifying Body: A technically competent body (organization or firm, public or private) that issues a Reference Material Certificate. The only generally accepted certifying body in the United States is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD.


Reference Material (RM): A material or substance with one or more properties which are sufficiently well established to be used for calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): A reference material with one or more properties whose values are certified by a technically valid procedure accompanied by or traceable to a certificate or other documentation, which is issued by a Certifying Body.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen and Oxygen are the result of combustion instrument procedures.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length. The majority of materials are in wrought condition. Other methods of manufacture are utilized as a last resort, only in the case of those materials being unavailable in wrought condition. "Batch" samples are taken by removing a one-inch cross section for every thirteen inches of total length from the entire bar. Twenty-five percent of the one inch cross section is converted to chips for analysis by classical wet chemistry, ICP, AA, and combustion procedures and seventy-five percent remains in a solid disk form for OES and X-Ray analysis where applicable. Each member of the ILAP is furnished both a solid sample and the corresponding supply of chips from a specific location on the batch bar. This massive sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data.

Certified by: 
 William D. Britt, President/General Manager
 Analytical Reference Materials International

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